

# Search Notes



Application/Control No.

10/564,510

Examiner

John S. Chu

Applicant(s)/Patent under  
Reexamination

MASUDA ET AL.

Art Unit

1795

## SEARCHED

Class	Subclass	Date	Examiner
430	190	12/2007	jsr
430	191		
430	192		
430	193		
430	326		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST SEARCH UPDATED	12/2007	jsr